

<b>Notice of References Cited</b>	Application/Control No. 10/633,287		Applicant(s)/Patent Under Reexamination YAMANE, KENJI	
	Examiner Anthony Bantamoi		Art Unit 2609	Page 1 of 1

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*	A	US-2002/0162111	10-2002	Shimizu et al.	725/87
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NON-PATENT DOCUMENTS

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